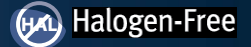


EPC2307 – Enhancement Mode Power Transistor

V_{DS} , 200 V

$R_{DS(on)}$, 10 mΩ max

PRELIMINARY



Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR} . The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

Application Notes:

- Easy-to-use and reliable gate, Gate Drive ON = 5 V typical, OFF = 0 V (negative voltage not needed)
- Top of FET is electrically connected to source

Questions:



EPC2307

Package size: 3 x 5 mm

Applications

- Synchronous Rectification
- AC/DC chargers, SMPS, adaptors
- High Frequency DC-DC Conversion
- Class D audio
- Wireless Power
- High power lidar & dToF

Benefits

- Higher Efficiency – Lower conduction and switching losses, zero reverse recovery losses
- Ultra Small Footprint – Higher power density

Maximum Ratings			
PARAMETER		VALUE	UNIT
V_{DS}	Drain-to-Source Voltage (Continuous)	200	V
	Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	240	
I_D	Continuous ($T_A = 25^\circ\text{C}$)	48	A
	Pulsed (25°C , $T_{PULSE} = 300 \mu\text{s}$)	130	
V_{GS}	Gate-to-Source Voltage	6	V
	Gate-to-Source Voltage	-4	
T_J	Operating Temperature	-40 to 150	$^\circ\text{C}$
T_{STG}	Storage Temperature	-40 to 150	

Static Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
BV_{DSS}	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V}$, $I_D = [\text{TBD}]$	200			V
I_{DSS}	Drain-Source Leakage	$V_{GS} = 0 \text{ V}$, $V_{DS} = 160 \text{ V}$		0.002		mA
I_{GSS}	Gate-to-Source Forward Leakage	$V_{GS} = 5 \text{ V}$		0.006		
	Gate-to-Source Forward Leakage [#]	$V_{GS} = 5 \text{ V}$, $T_J = 125^\circ\text{C}$		0.4		
	Gate-to-Source Reverse Leakage	$V_{GS} = -4 \text{ V}$		0.002		
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 4 \text{ mA}$	0.8	1.1	2.5	V
$R_{DS(on)}$	Drain-Source On Resistance	$V_{GS} = 5 \text{ V}$, $I_D = 16 \text{ A}$		8.2	10	mΩ
V_{SD}	Source-Drain Forward Voltage [#]	$I_S = 0.5 \text{ A}$, $V_{GS} = 0 \text{ V}$		1.6		V

[#] Defined by design. Not subject to production test.

Scan QR code or click link below for more information including reliability reports, device models, demo boards!



<https://l.ead.me/EPC2307>

Dynamic Characteristics [#] (T _J = 25°C unless otherwise stated)						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
C _{ISS}	Input Capacitance	V _{DS} = 100 V, V _{GS} = 0 V		1401		pF
C _{RSS}	Reverse Transfer Capacitance			1.2		
C _{OSS}	Output Capacitance			326		
C _{OSS(ER)}	Effective Output Capacitance, Energy Related (Note 1)	V _{DS} = 0 to 100 V, V _{GS} = 0 V		445		pF
C _{OSS(TR)}	Effective Output Capacitance, Time Related (Note 2)			579		
Q _G	Total Gate Charge	V _{DS} = 100 V, V _{GS} = 5 V, I _D = 16 A		10.6		nC
Q _{GD}	Gate-to-Drain Charge	V _{DS} = 100 V, I _D = 16 A		1.3		
Q _{OSS}	Output Charge	V _{DS} = 100 V, V _{GS} = 0 V		58		
Q _{RR}	Source-Drain Recovery Charge			0		

All measurements were done with substrate shorted to source.

Defined by design. Not subject to production test.

Note 1: C_{OSS(ER)} is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Note 2: C_{OSS(TR)} is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Figure 1: Typical Output Characteristics at 25°C

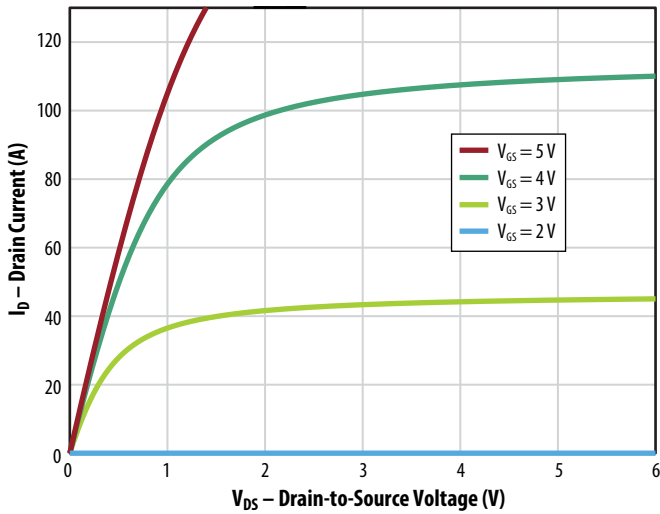


Figure 2: Typical Transfer Characteristics

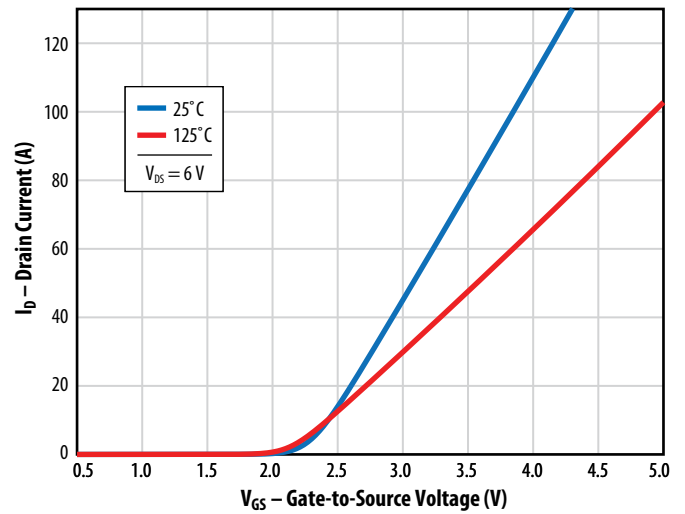


Figure 3: Typical R_{DS(on)} vs. V_{GS} for Various Drain Currents

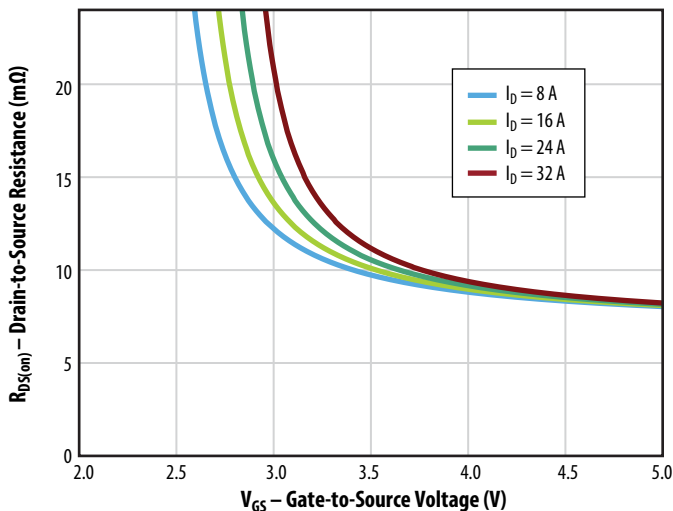


Figure 4: Typical R_{DS(on)} vs. V_{GS} for Various Temperatures

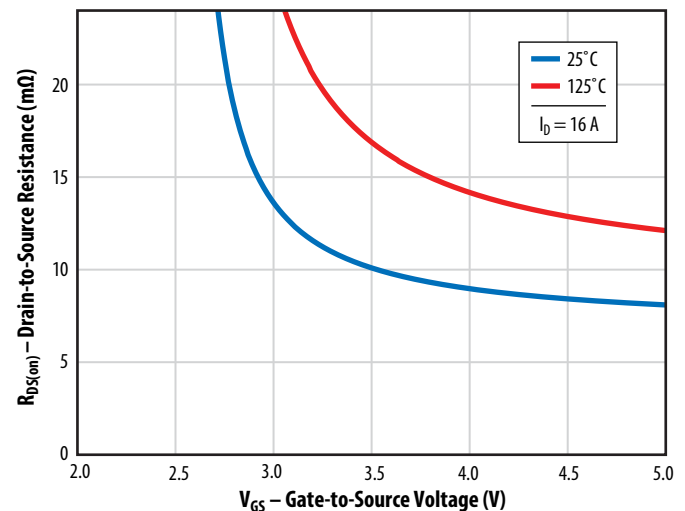


Figure 5a: Typical Capacitance (Linear Scale)

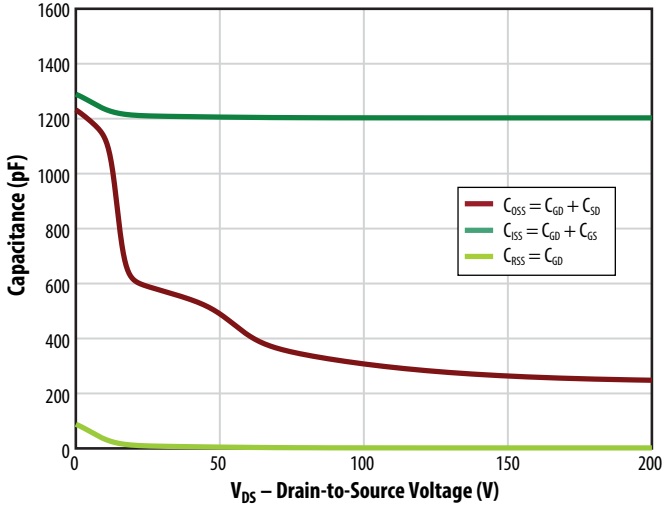


Figure 5b: Typical Capacitance (Log Scale)

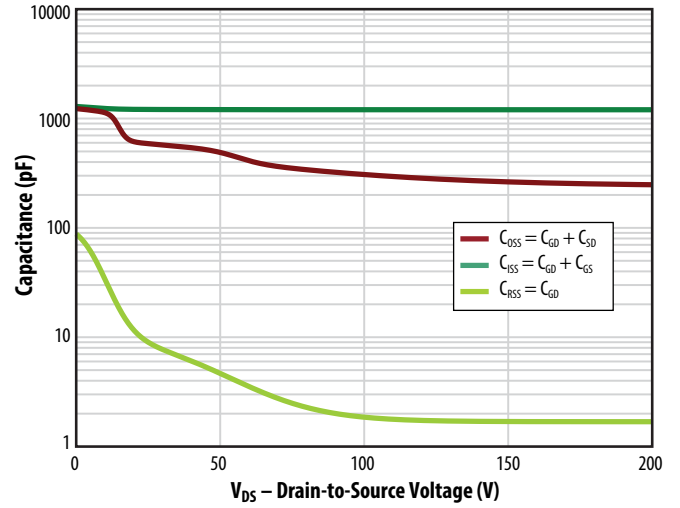


Figure 6: Typical Output Charge and C_{oss} Stored Energy

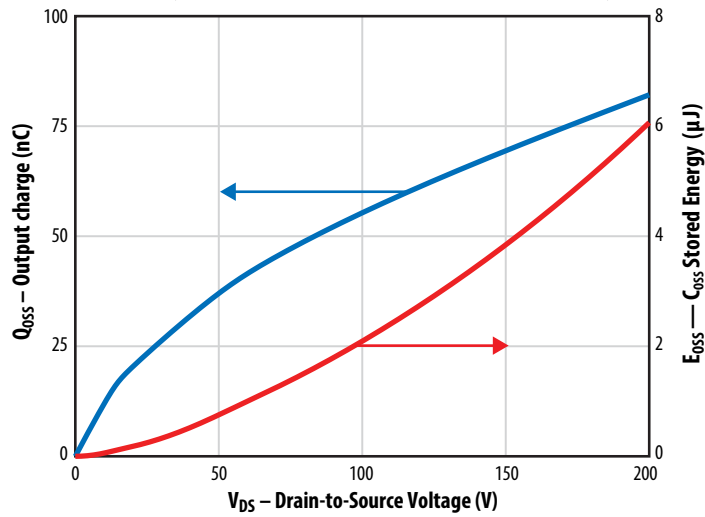


Figure 7: Typical Gate Charge

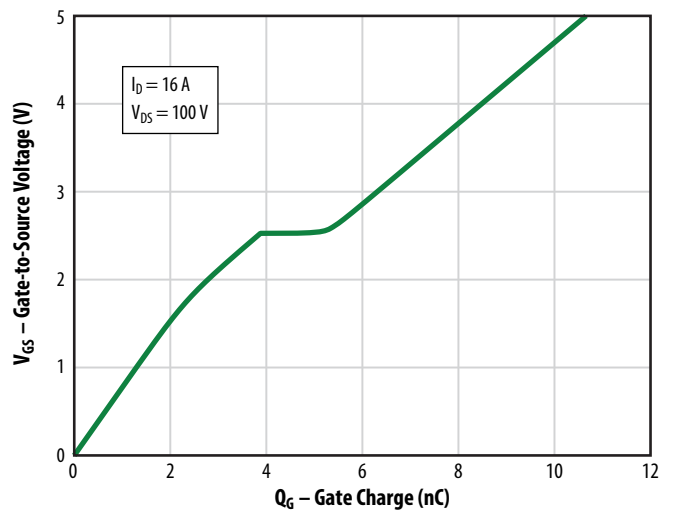
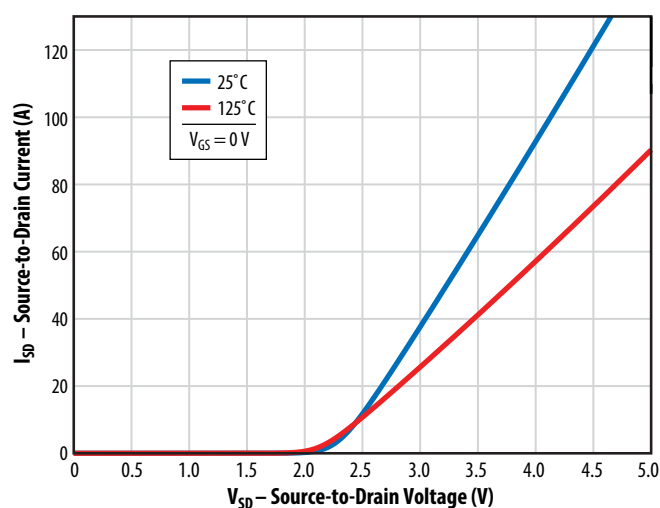


Figure 8: Typical Reverse Drain-Source Characteristics



Note: Negative gate drive voltage increases the reverse drain-source voltage. EPC recommends 0V for OFF.

Figure 9: Typical Normalized On-State Resistance vs. Temp.

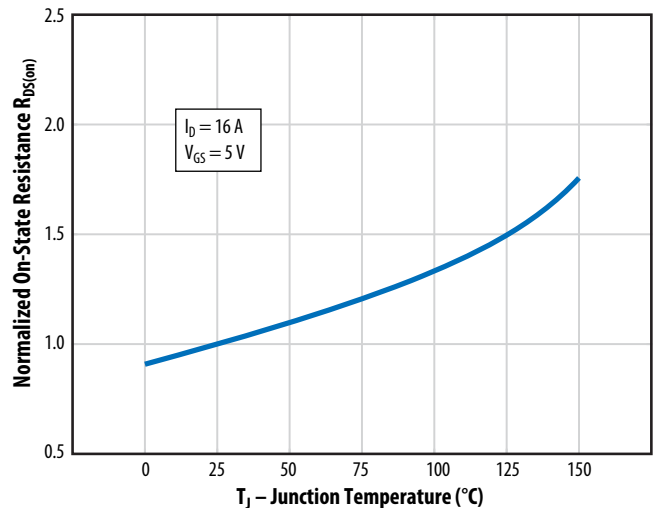
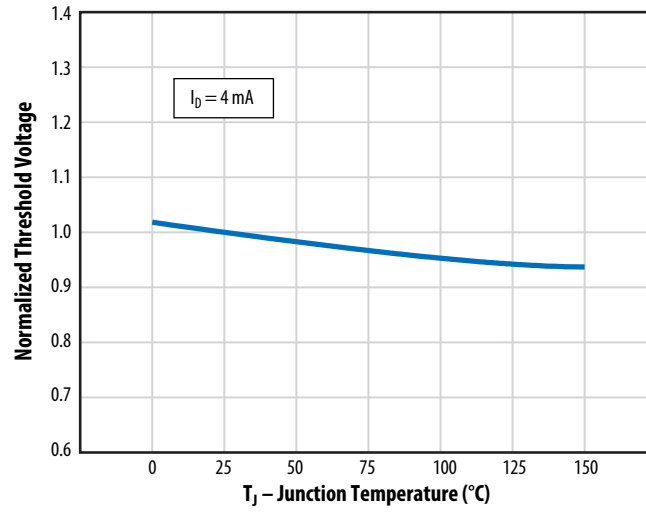
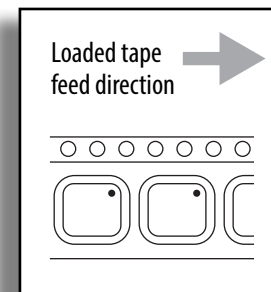
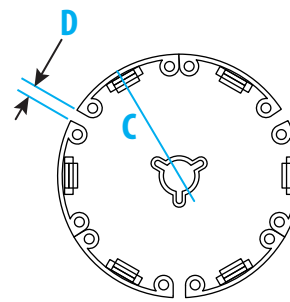
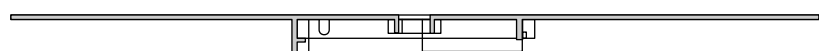
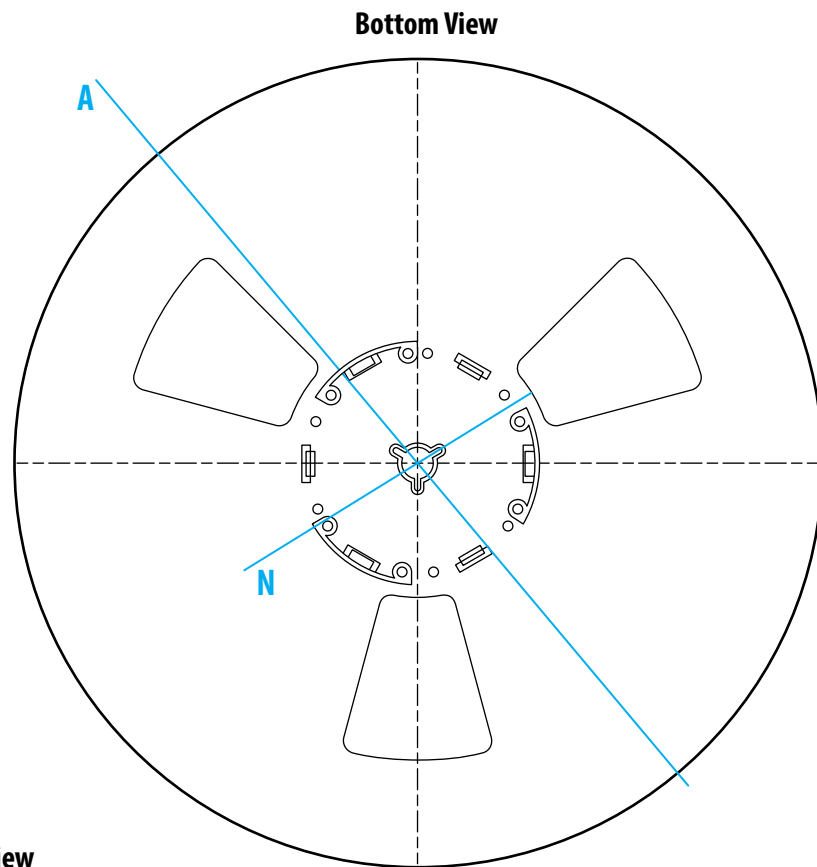
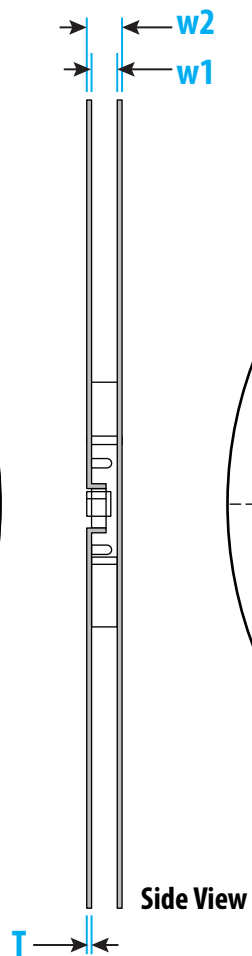
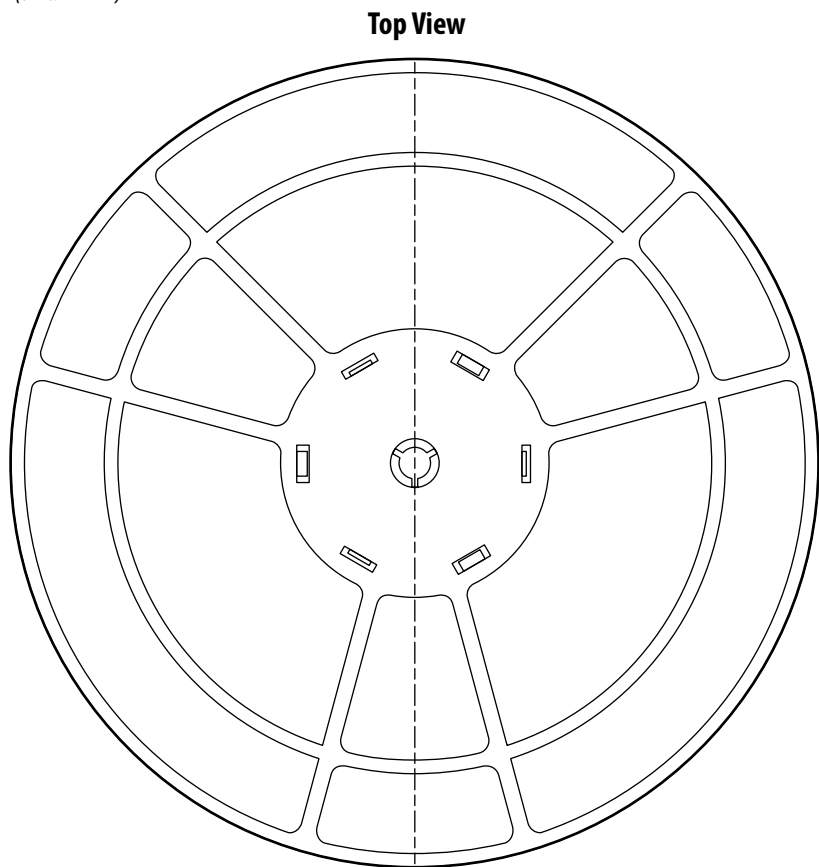


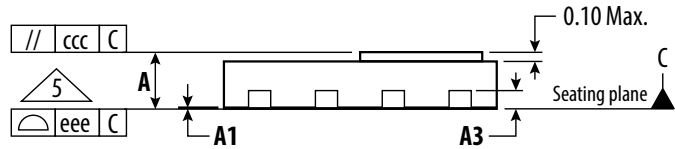
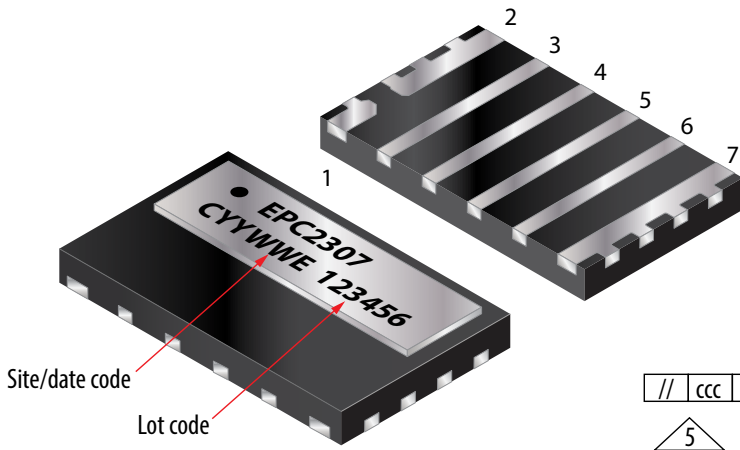
Figure 10: Typical Normalized Threshold Voltage vs. Temp.

TAPE AND REEL

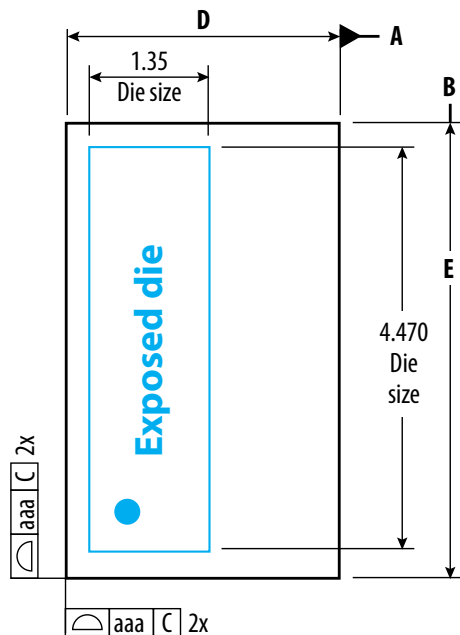
(units in mm)



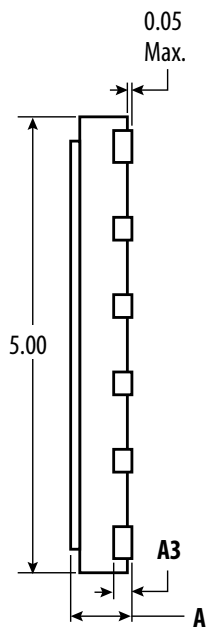
Type	A	N	C	D	w1	w2	T
8MM	$\text{Ø}330\pm 2$	$\text{Ø}100\pm 2$	$\text{Ø}13.1\pm 0.2$	5.6 ± 0.5	$8.4+1.5$	14.4	2.1 ± 0.5
12MM	$\text{Ø}330\pm 2$	$\text{Ø}100\pm 2$	$\text{Ø}13.1\pm 0.2$	5.6 ± 0.5	$12.4+1.5$	18.4	2.1 ± 0.5
16MM	$\text{Ø}330\pm 2$	$\text{Ø}100\pm 2$	$\text{Ø}13.1\pm 0.2$	5.6 ± 0.5	$16.4+1.5$	22.4	2.1 ± 0.5
24MM	$\text{Ø}330\pm 2$	$\text{Ø}100\pm 2$	$\text{Ø}13.1\pm 0.2$	5.6 ± 0.5	$24.4+1.5$	30,4	2.1 ± 0.5



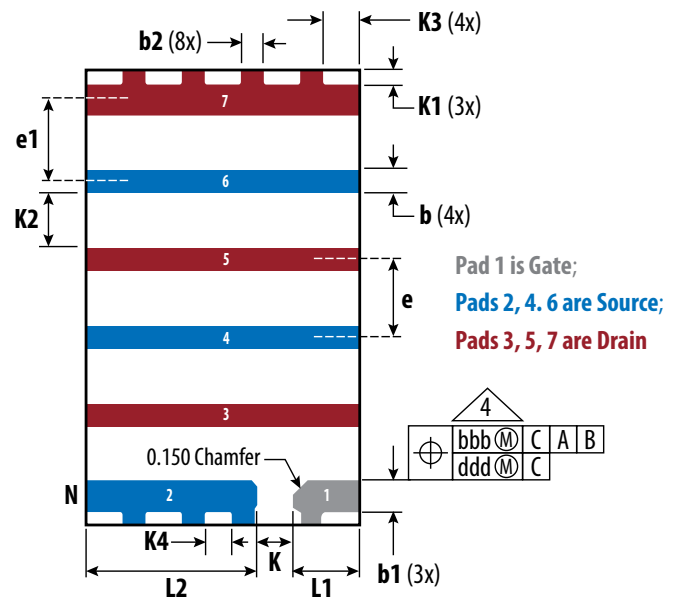
Side View 2



Top View



Side View 1



Bottom View

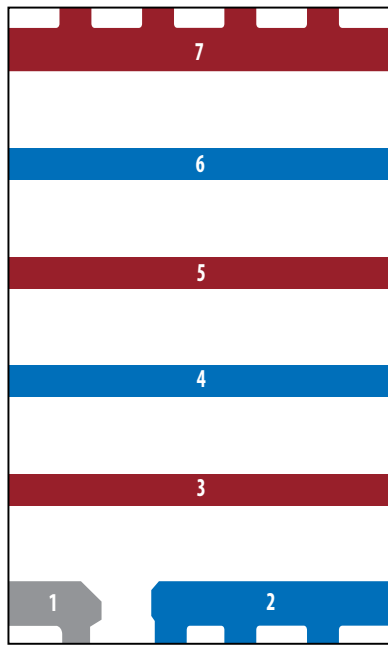
SYMBOL	Dimension (mm)			Note
	MIN	Nominal	MAX	
A	0.60	0.65	0.70	
A1	0.00	0.02	0.05	
A3		0.20 Ref		
b	0.20	0.25	0.30	4
b1	0.30	0.35	0.40	4
b2	0.20	0.25	0.30	4
D		3.00 BSC		
E		5.00 BSC		
e		0.85 BSC		
e1		0.90 BSC		
L1	0.625	0.725	0.825	
L2	1.775	1.875	1.975	

SYMBOL	Dimension (mm)			Note
	MIN	Nominal	MAX	
K	0.35	0.40	0.45	
K1	0.10	0.15	0.20	
K2	0.55	0.60	0.65	
K3	0.35	0.40	0.45	
K4	0.25	0.30	0.35	
aaa		0.05		
bbb		0.10		
ccc		0.10		
ddd		0.05		
eee		0.08		
N		15		3
NE		6		

Notes:

1. Dimensioning and tolerancing conform to ASME Y14.5-2009
2. All dimensions are in millimeters
3. N is the total number of terminals
4. Dimension b applies to the metallized terminal. If the terminal has a radius on the other end of it, dimension b should not be measured in that radius area.
5. Coplanarity applies to the terminals and all the other bottom surface metallization.

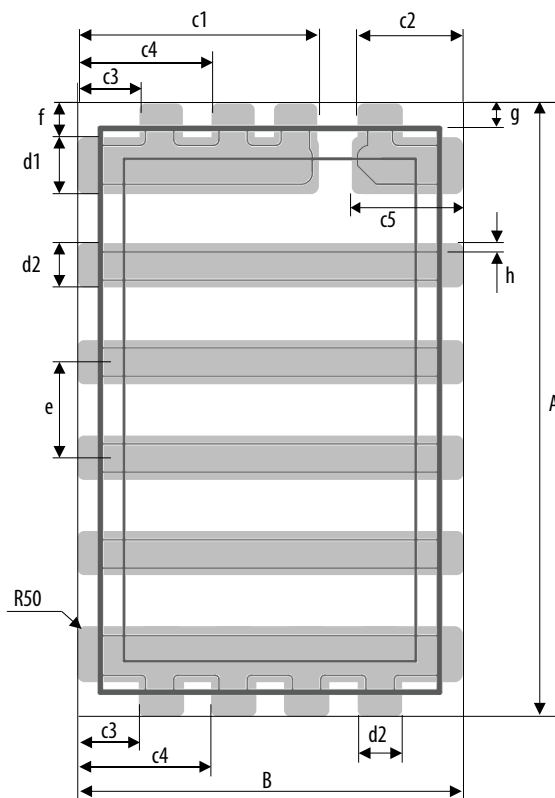
TRANSPARENT VIEW



Transparent Top View

PIN	DESCRIPTION
1	Gate
2	Source
3	Drain
4	Source
5	Drain
6	Source
7	Drain

RECOMMENDED LAND PATTERN
(units in mm)



Land pattern is solder mask defined.

DIM	Nominal
A	5.4
B	3.4
c1	2.11
c2	0.90
c3	0.55
c4	1.20
c5	0.975
d1	0.45
d2	0.35
e	0.85
f	0.30
g	0.2
h	0.05

Additional resources available:

- Assembly resources – https://epc-co.com/epc/Portals/0/epc/documents/product-training/Appnote_GaNassembly.pdf
- Library of Altium footprints for production FETs and ICs – <https://epc-co.com/epc/documents/altium-files/EPC%20Altium%20Library.zip>
(for preliminary device Altium footprints, contact EPC)

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